

# 100V 115mΩ N-Ch Power MOSFET

**Features**

- Low Gate Charge
- 100% UIS Tested, 100% R<sub>g</sub> Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant

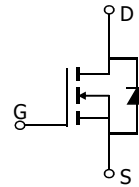
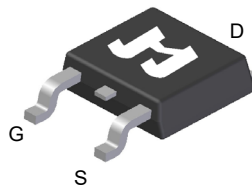
**Applications**

- Power Management in Telecom., Industrial Automation, CE
- Current Switching in DC/DC & AC/DC Sub-systems

**Product Summary**

Parameter	Typ.	Unit
V <sub>DS</sub>	100	V
V <sub>GS(th)</sub>	1.7	V
I <sub>D</sub> (@ V <sub>GS</sub> = 10V) <sup>(1)</sup>	6	A
R <sub>DS(ON)</sub> (@ V <sub>GS</sub> = 10V)	115	mΩ
R <sub>DS(ON)</sub> (@ V <sub>GS</sub> = 4.5V)	144	mΩ

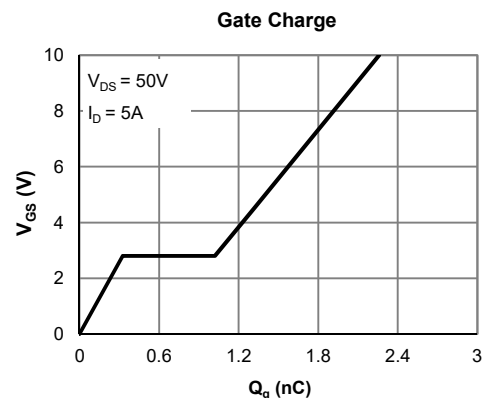
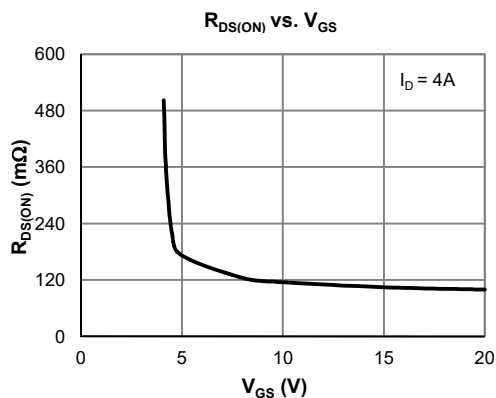
TO-252-3L Top View


**Ordering Information**

Device	Package	# of Pins	Marking	MSL	T <sub>J</sub> (°C)	Media	Quantity (pcs)
JMSL10130AK-13	TO-252-3L	3	SL10130A	1	-55 to 150	13-inch Reel	2500

**Absolute Maximum Ratings** (@ T<sub>A</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DS</sub>	100	V
Gate-to-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current <sup>(1)</sup>	I <sub>D</sub>	T <sub>C</sub> = 25°C	6
		T <sub>C</sub> = 100°C	4
Pulsed Drain Current <sup>(2)</sup>	I <sub>DM</sub>	10	A
Avalanche Current <sup>(3)</sup>	I <sub>AS</sub>	1.8	A
Avalanche Energy <sup>(3)</sup>	E <sub>AS</sub>	4.9	mJ
Power Dissipation <sup>(4)</sup>	P <sub>D</sub>	T <sub>C</sub> = 25°C	17
		T <sub>C</sub> = 100°C	7
Junction & Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C



**Electrical Characteristics** (@  $T_J = 25^\circ\text{C}$  unless otherwise specified)

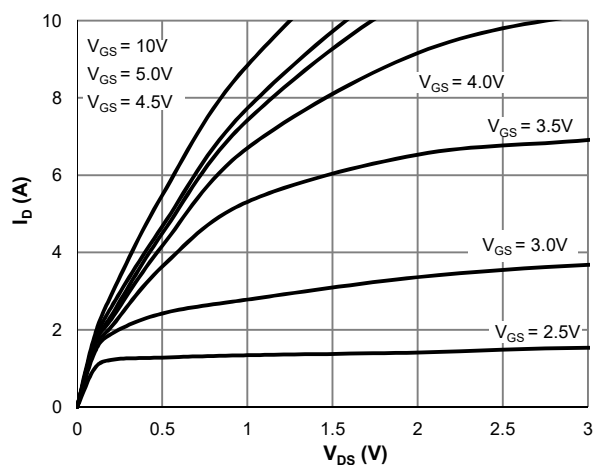
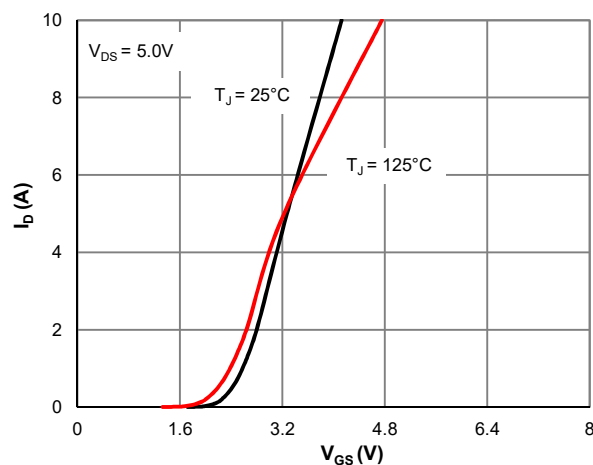
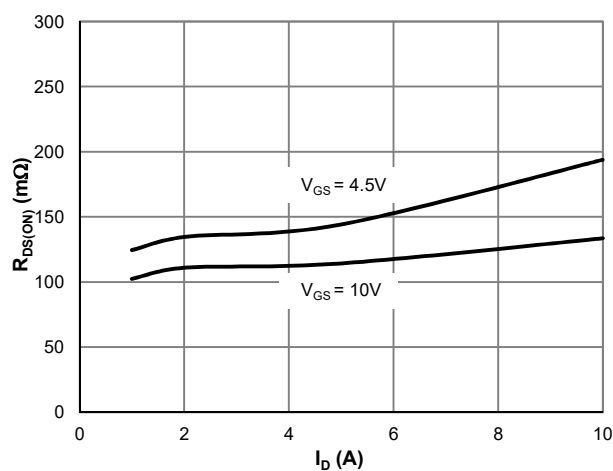
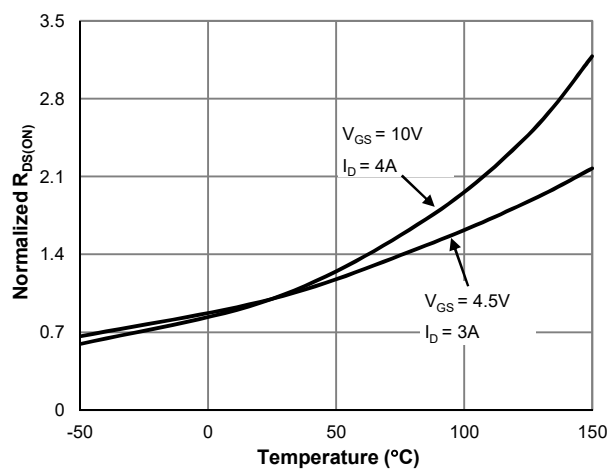
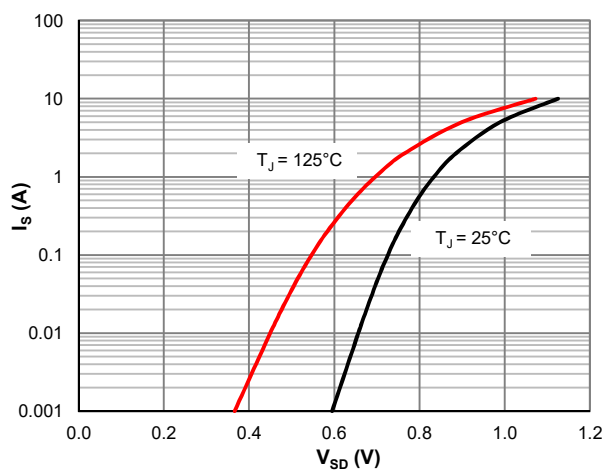
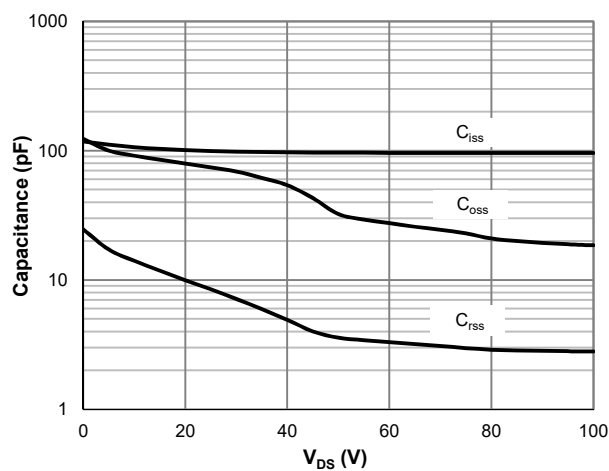
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	100			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 80\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0 5.0	$\mu\text{A}$
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.7	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{V}, I_D = 4\text{A}$		115	138	m $\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 3\text{A}$		144	180	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5\text{V}, I_D = 4\text{A}$		5.8		S
Diode Forward Voltage	$V_{SD}$	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.7	1.0	V
Diode Continuous Current	$I_S$	$T_C = 25^\circ\text{C}$			17	A
<b>DYNAMIC PARAMETERS</b> <sup>(5)</sup>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}, V_{DS} = 50\text{V}, f = 1\text{MHz}$		96		pF
Output Capacitance	$C_{oss}$			32		pF
Reverse Transfer Capacitance	$C_{rss}$			3.6		pF
Gate Resistance	$R_g$	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		2.9		$\Omega$
<b>SWITCHING PARAMETERS</b> <sup>(5)</sup>						
Total Gate Charge (@ $V_{GS} = 10\text{V}$ )	$Q_g$	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 50\text{V}, I_D = 5\text{A}$		2.3		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$ )	$Q_g$			1.3		nC
Gate Source Charge	$Q_{gs}$			0.3		nC
Gate Drain Charge	$Q_{gd}$			0.7		nC
Turn-On Delay Time	$t_{D(on)}$	$V_{GS} = 10\text{V}, V_{DS} = 50\text{V}$ $R_L = 10\Omega, R_{GEN} = 6\Omega$		2.1		ns
Turn-On Rise Time	$t_r$			3.3		ns
Turn-Off Delay Time	$t_{D(off)}$			7.2		ns
Turn-Off Fall Time	$t_f$			3.2		ns
Body Diode Reverse Recovery Time	$t_{rr}$		$I_F = 5\text{A}, dI_F/dt = 100\text{A}/\mu\text{S}$		25	
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F = 5\text{A}, dI_F/dt = 100\text{A}/\mu\text{S}$		15		nC

**Thermal Performance**

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	48	58	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	6.0	7.5	$^\circ\text{C}/\text{W}$

**Notes:**

1. Computed continuous current assumes the condition of  $T_{J\_Max}$  while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under  $T_{J\_Max} = 150^\circ\text{C}$ .
3. This single-pulse measurement was taken under the following condition [ $L = 3\text{mH}, V_{GS} = 10\text{V}, V_{DD} = 50\text{V}$ ] while its value is limited by  $T_{J\_Max} = 150^\circ\text{C}$ .
4. The power dissipation  $P_D$  is based on  $T_{J\_Max} = 150^\circ\text{C}$ .
5. This value is guaranteed by design hence it is not included in the production test.

**Typical Electrical & Thermal Characteristics**

**Figure 1: Saturation Characteristics**

**Figure 2: Transfer Characteristics**

**Figure 3:  $R_{DS(ON)}$  vs. Drain Current**

**Figure 4:  $R_{DS(ON)}$  vs. Junction Temperature**

**Figure 5: Body-Diode Characteristics**

**Figure 6: Capacitance Characteristics**



Typical Electrical & Thermal Characteristics

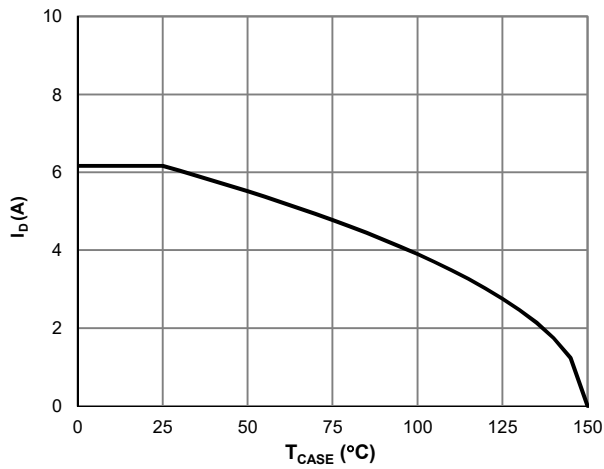


Figure 7: Current De-rating

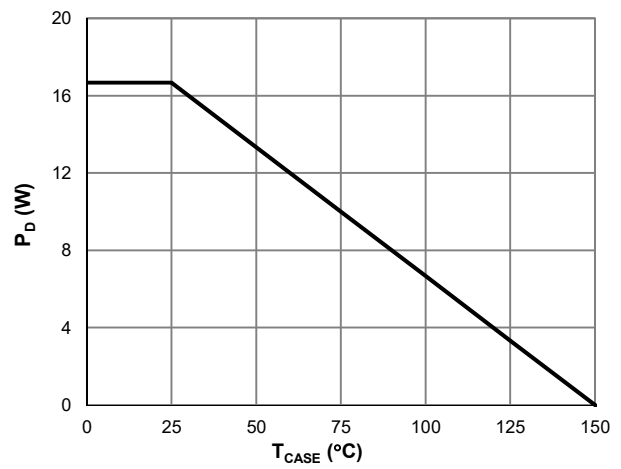


Figure 8: Power De-rating

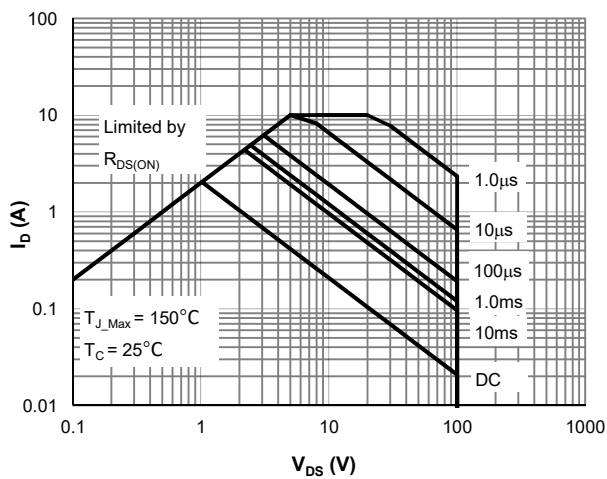


Figure 9: Maximum Safe Operating Area

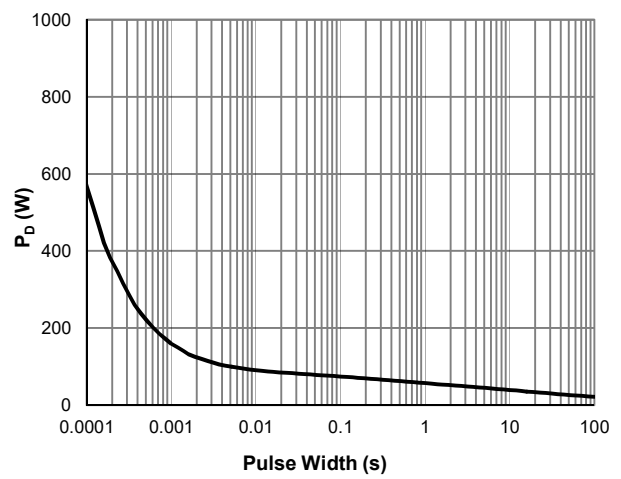


Figure 10: Single Pulse Power Rating, Junction-to-Case

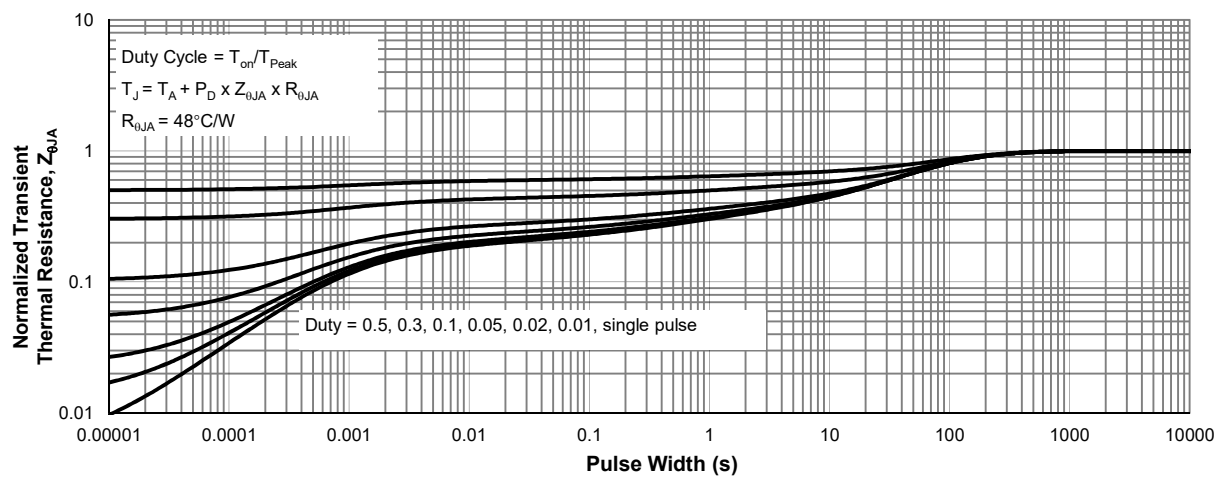
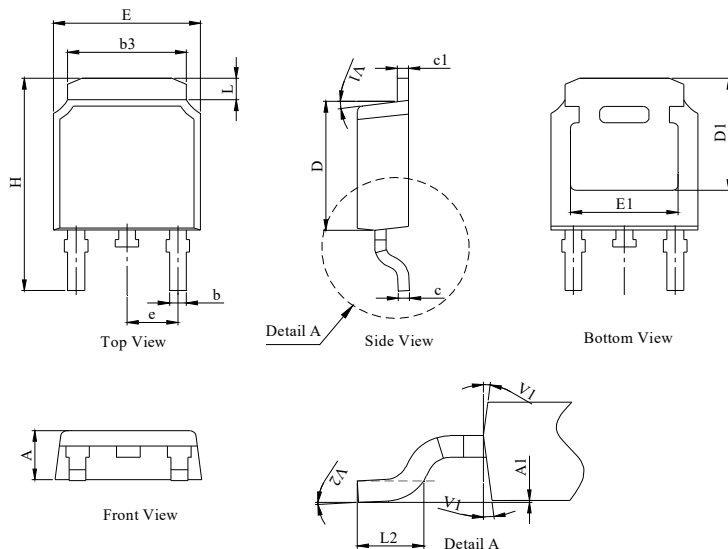
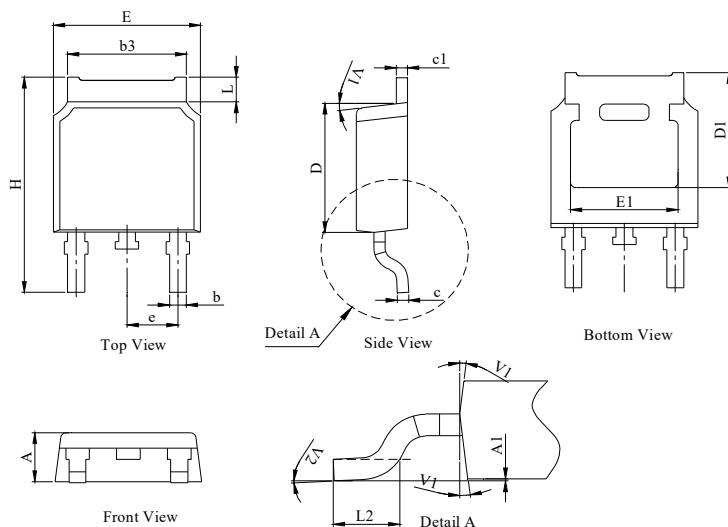


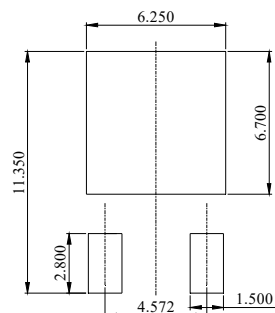
Figure 11: Normalized Maximum Transient Thermal Impedance

**TO-252-3L Package Information**
**Package Outline Type-A**


DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.18	2.30	2.39
A1	0	--	0.13
b	0.64	0.76	0.89
c	0.40	0.50	0.61
c1	0.46	0.50	0.58
D	5.97	6.10	6.23
D1	5.05	--	--
E	6.35	6.60	6.73
E1	4.32	--	--
b3	5.21	5.38	5.55
e	2.29 BSC		
H	9.40	10.00	10.40
L	0.89	--	1.27
L2	1.40	--	1.78
V1	7° REF		
V2	0°	--	6°

**Package Outline Type-B**


DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.10	2.30	2.40
A1	0	--	0.13
b	0.66	0.76	0.86
b3	5.21	5.38	5.55
c	0.40	0.50	0.60
c1	0.44	0.50	0.58
D	5.90	6.10	6.30
D1	5.30REF		
E	6.40	6.60	6.80
E1	4.63	-	-
e	2.29 BSC		
H	9.50	10.00	10.70
L	1.09	--	1.21
L2	1.35	--	1.65
V1	7° REF		
V2	0°	--	6°

**Recommended Soldering Footprint**


DIMENSIONS: MILLIMETERS